Appl. No. 10/748,734 Amdt. Dated August 26, 2005 Reply to Office Action of March 30, 2005

Attorney Docket No. 88519.0001 Customer No.: 26021

Amendments to the Claims:

This listing of claims will replace all prior versions, and listings, of claims in the application:

Listing of Claims:

- 1. (Original) A transparent electrode made up of ZnO as its main material, wherein its surface is covered with a Mg-doped ZnO film.
 - 2. (New) A transparent electrode comprising:

a ZnO layer; and

an Mg-doped ZnO film formed on the ZnO layer.

- 3. (New) The transparent electrode of Claim 2, wherein the ZnO layer is formed on a semiconductor layer.
- 4. (New) The transparent electrode of Claim 3, wherein the semiconductor layer comprises a GaN system semiconductor layer.
- 5. (New) The transparent electrode of Claim 3, wherein the semiconductor layer comprises an n-type GaN system semiconductor layer formed on a substrate, an emission layer formed on the n-type GaN system semiconductor layer, and a p-type GaN system semiconductor layer formed on the emission layer.
- 6. (New) The transparent electrode of Claim 2, wherein the Mg-doped ZnO film overlies an upper surface of the ZnO layer.
- 7. (New) The transparent electrode of Claim 2, wherein the Mg-doped ZnO film overlies an upper surface and side surfaces of the ZnO layer.
- 8. (New) The transparent electrode of Claim 2, wherein a first metal pattern is formed on the Mg-doped ZnO film.

Page 2 of 8

P.009/014

Attorney Docket No. 88519.0001 Customer No.: 26021

- 9. (New) The transparent electrode of Claim 3, wherein a second metal pattern is formed on the semiconductor layer.
- 10. (New) The transparent electrode of Claim 2, wherein the Mg-doped ZnO film improves acid resistance of the transparent electrode.
- 11. (New) The transparent electrode of Claim 3, wherein the semiconductor layer is formed on a substrate.
 - 12. (New) A light emitting device comprising:
 - a semiconductor layer formed on a substrate;
 - a ZnO transparent electrode formed on the semiconductor layer; and an Mg-doped ZnO film formed on the ZnO transparent electrode.
- 13. (New) The light emitting device of Claim 12, wherein the semiconductor layer comprises a GaN system semiconductor layer.
- 14. (New) The light emitting device of Claim 12, wherein the semiconductor layer comprises an n-type GaN system semiconductor layer formed on the substrate, an emission layer formed on the n-type GaN system semiconductor layer, and a p-type GaN system semiconductor layer formed on the emission layer.
- 15. (New) The light emitting device of Claim 12, wherein the Mg-doped ZnO film overlies an upper surface of the ZnO transparent electrode formed on the semiconductor layer.
- 16. (New) The light emitting device of Claim 12, wherein the Mg-doped ZnO film overlies an upper surface and side surfaces of the ZnO transparent electrode formed on the semiconductor layer.
- 17. (New) The light emitting device of Claim 12, wherein a first metal pattern is formed on the Mg-doped ZnO film.

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- 18. (New) The light emitting device of Claim 12, wherein a second metal pattern is formed on the semiconductor layer.
- 19. (New) The light emitting device of Claim 12, wherein the Mg-doped ZnO film improves acid resistance of the light emitting device.
 - 20. (New) A light emitting device comprising:
 - a semiconductor layer formed on a substrate;
 - a ZnO transparent electrode formed on the semiconductor layer; and an Mg-doped ZnO film formed on an upper surface and side surfaces of the ZnO transparent electrode.
- 21. (New) The light emitting device of Claim 20, wherein the semiconductor layer comprises a GaN system semiconductor layer.
- 22. (New) The light emitting device of Claim 20, wherein the semiconductor layer comprises an n-type GaN system semiconductor layer formed on the substrate, an emission layer formed on the n-type GaN system semiconductor layer, and a p-type GaN system semiconductor layer formed on the emission layer.
- 23. (New) The light emitting device of Claim 20, wherein a first metal pattern is formed on the Mg-doped ZnO film.
- 24. (New) The light emitting device of Claim 20, wherein a second metal pattern is formed on the semiconductor layer.
- 25. (New) The light emitting device of Claim 20, wherein the Mg-doped ZnO film improves acid resistance of the light emitting device.